

2.4 GHz Bluetooth Class 1 Power Amplifier IC Preliminary Information

Applications

- Bluetoothtm Class 1
- USB Dongles
- □ Laptops
- Access Points
- Cordless Piconets
- Flip chip and chip-on-board applications

Features

- → +22.5 dBm at 47% Power Added Efficiency
- □ Low current 80 mA typical @ Pout=+20 dBm
- Temperature stability better than 1dB
- Power-control and Power-down modes
- □ -40C to +85C temperature range
- ☐ Gold bump bare die (0.63mm x 0.96mm)

Ordering Information

Part	Package	Shipping Method		
PA2423G	Gold bump bare die	Diced wafer Waffle pack		
PA2423G-EV	Evaluation kit			

Product Description

A monolithic, high-efficiency, silicon-germanium power amplifier IC, the PA2423G is designed for Class 1 Bluetoothtm 2.4 GHz radio applications. It delivers +22.5 dBm output power with 47% power-added efficiency – making it capable of overcoming insertion losses of up to 2.5 dB between amplifier output and antenna input in Class 1 Bluetoothtm applications.

The amplifier features:

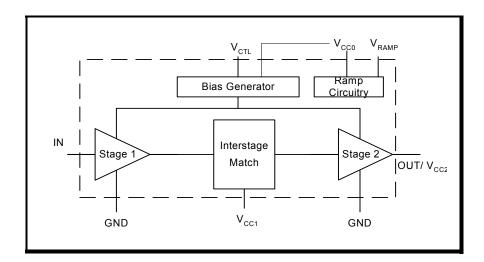
- an analog control input for improving PAE at reduced output power levels;
- a digital control input for controlling power up and power down modes of operation.

An on-chip ramping circuit corrects the turn-on/off switching of amplifier output with less than 3 dB overshoot, meeting the Bluetoothtm specification 1.1.

The PA2423G operates at 3.3V DC. At typical output power level (+22.5 dBm), its current consumption is 120 mA.

The silicon/silicon-germanium structure of the PA2423G provides high thermal conductivity and a subsequently low junction temperature. This device is capable of operating at a duty cycle of 100 percent.

Functional Block Diagram





Pad Description

For reference of pad numbers to the package drawings, see pages 4 and 5.

Number	Name	Description	Pad Coordinate, Center of Pad (lower left corner is (0.0))
1	IN	PA input	X = 192μm ± 10μm, Y = 315μm ± 10μm
2	VRAMP	PA enable/disable control input	X = 192μm ± 10μm, Y = 515μm ± 10μm
3	GND1	Ground	X = 352μm ± 10μm, Y = 515μm ± 10μm
4	VCTL	Output power level control	X = 512μm ± 10μm, Y = 515μm ± 10μm
5	GND2	Ground	X = 672μm ± 10μm, Y = 515μm ± 10μm
6	GND3	Ground	X = 832μm ± 10μm, Y = 515μm ± 10μm
7	OUT/VCC2	PA output and stage2 collector supply voltage	X = 752μm ± 10μm, Y = 315μm ± 10μm
8	GND4	Ground	X = 832μm ± 10μm, Y = 115μm ± 10μm
9	GND5	Ground	X = 672μm ± 10μm, Y = 115μm ± 10μm
10	VCC1	Stage1 collector supply voltage	X = 512μm ± 10μm, Y = 115μm ± 10μm
11	GND6	Ground	X = 352μm ± 10μm, Y = 115μm ± 10μm
12	VCC0	Ramp supply voltage	X = 192μm ± 10μm, Y = 115μm ± 10μm

Absolute Maximum Ratings

Symbol	Parameter	Min.	Max.	Unit
VCC	Supply Voltage	-0.3	+3.6	V
VCTL	Control Voltage	-0.3	V_{CC}	V
VRAMP	Ramping Voltage	-0.3	V _{CC}	٧
IN	RF Input Power		+8	dBm
TA	Operating Temperature Range	-40	+85	°C
TSTG	Storage Temperature Range	-40	+150	°C
Tj	Maximum Junction Temperature		+150	°C

Operation in excess of any one of the above Absolute Maximum Ratings may result in permanent damage. This device is a high performance RF integrated circuit with EST rating < 600V and is ESD sensitive. Handling and assembly of this device should be at ESD protected workstations.



DC Electrical Characteristics

Conditions: $V_{CCO} = V_{CC1} = V_{CC2} = V_{RAMP} = 3.3V$, $V_{CTL} = 3.3V$, $P_{IN} = +2dBm$, $TA = 25^{\circ}C$, f = 2.45GHz, Input and Output externally matched to 500, unless otherwise noted

Symbol	Note	Parameter	Min.	Тур.	Max.	Unit
Vcc		Supply Voltage	3.0	3.3	3.6	٧
Icc	1	Supply Current (Icc = Ivcc0 + Ivcc1 + Ivcc2)		120	150	mA
ΔICC_{temp}	3	Supply Current variation over temperature, (-40°C < TA <+85°C)		25		%
VCTL		PA Output Power Control Voltage Range	0		Vcc	V
ICTL	1	Current sourced by VCTL Pin		200	250	μΑ
VRAMP	3	Logic High Voltage	2.0			٧
VRAIVIP	3	Logic Low Voltage			0.8	٧
I _{stby}	1	Leakage Current when VRAMP = 0V		0.5	10	μΑ

AC Electrical Characteristics

Conditions: $V_{CC0} = V_{CC1} = V_{CC2} = V_{RAMP} = 3.3V$, $V_{CTL} = 3.3V$, $P_{IN} = +2 \text{ dBm}$, $T_A = 25^{\circ}\text{C}$, f = 2.45GHz,

Input and Output externally matched to 50Ω , unless otherwise noted

Symbol	Note	Parameter	Min	Тур.	Мах	Unit
fL-U	3	Frequency Range	240 0		2500	MHz
Роит	1	Output Power @ PIN =+2 dBm,VcTL = 3.3V	20.0	22.5	23.5	dBm
POUT	1	Output Power @ PIN =+2 dBm,VcTL =0.4V		-8	0	dBm
ΔP_{TEMP}	3	Pout variation over temperature (-40°C <ta <+85°c),="" vctl="3.3V</td"><td></td><td>1</td><td>2</td><td>dB</td></ta>		1	2	dB
dP out /dVctl	3	Control Voltage Sensitivity		60	120	dBmV
PAE		Power Added Efficiency at +22.5 dBm Output Power		47		%
Gvar	3	Gain Variation over band (2400-2500 MHz)		0.7	1	dB
2f, 3f, 4f, 5f	3,4	Harmonics		-35	-30	dBc
IS21IOFF	2	Isolation in "OFF" State, PIN =+2dBm, VRAMP =0V	20	25		dB
IS ₁₂ I	2	Reverse Isolation	32	42		dB
STAB	2	Stability (PIN = +2dBm, Load VSWR = 6:1)	All non-harmonically related outputs less than -50 dBc			

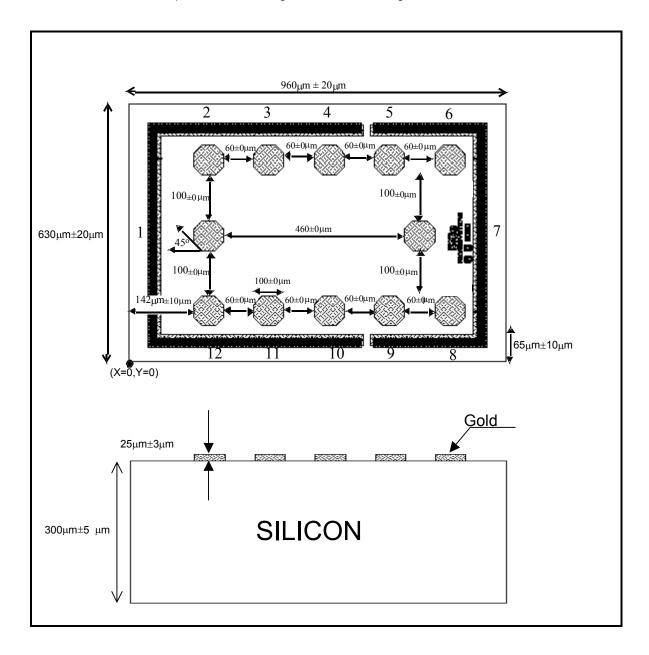
Notes: (1) Guaranteed by production test at TA = 25° C.

- (2) Guaranteed by design only.
- (3) Guaranteed by design and characterization.
- (4) Harmonic levels are greatly affected by topology of external matching networks.
- (5) RF characteristics specified above are for direct die attach (Flip-chip) on SiGe Applications Board. For wire bonded applications there may be some degradation in performance due to effects of bond wires and interconnect.



Gold Bump Bare Die - Top and Side Views

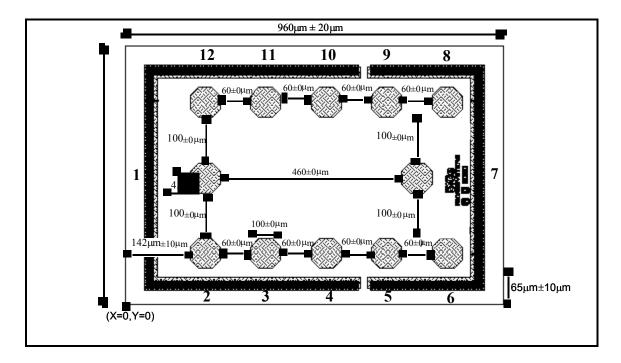
The first drawing provides the top view of the gold bump bare die (gold bumps on top surface). This view should be used for the chip-on-board mounting. The second drawing illustrates the side view of the die.





Gold Bump Bare Die - Bottom View

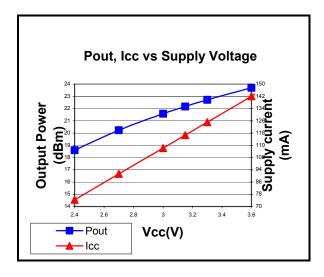
This drawing shows the gold bump bare die when viewed from the bottom of the die (without gold bumps). This view and pintout orientation should be used for flip chip mounting – top surface of die (with gold bumps) is inverted to make contact with PCB.

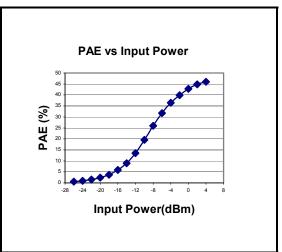


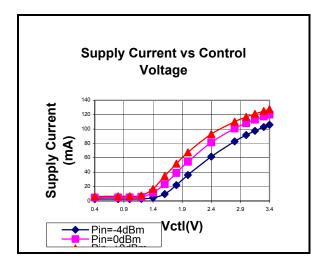


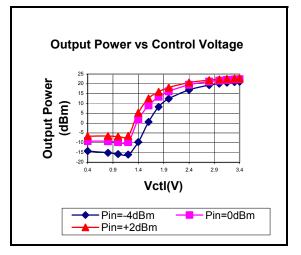
Typical Performance Characteristics

SiGe PA2423G-EV evaluation board, $V_{CC0}=V_{CC1}=V_{CC2}=V_{RAMP}=3.3V$, $V_{CTL}=3.3V$, $P_{IN}=+2$ dBm, $T_A=25$ °C, f=2.45GHz, Input and Output externally matched to 50Ω , unless otherwise noted)



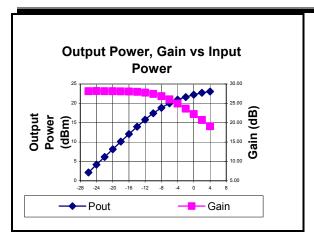


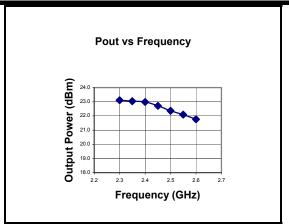


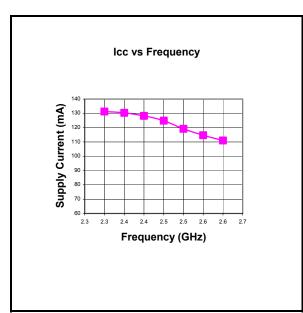


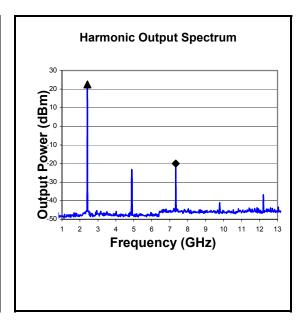


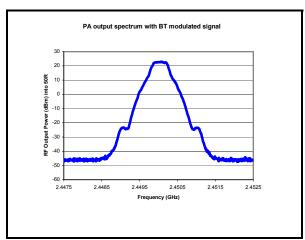
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Applications Information

For test and design purposes, SiGe Semiconductor offers an evaluation board for the PA2423G. The order part number is PA2423G-EV. The evaluation board is intended to simplify the testing with respect to RF performance of this power amplifier.

The application note, 05AN007 provides the supporting information for using the evaluation board. It contains information on the schematic, bill of materials and recommended layout for the power amplifier and the input and output matching networks. To assist in the design process, this layout is available, upon request, in gerber file format.

Using V_{RAMP}

 V_{RAMP} is a digital pin used to power-up and power-down the PA2423G in Time Duplex systems such as $Bluetooth^{tm}$ 1.1. During receive mode, V_{RAMP} voltage is pulled down, PA2423G acts as a 25 dB isolation block between the radio and the antenna while consuming a modest 1uA. In transmit mode, V_{RAMP} voltage is pulled to VCC and PA2423G offers 19 dB to 21dB of large signal gain. The rise and fall time are in the order of 1-2usec.

Using V_{CTL}

 V_{CTL} is an analog pin that is designed to control the gain of PA2423G. Applying a voltage between 0V and Vcc will adjust the gain between -15dB and 21 dB. Used in combination with a variable drive level to PA2423G, the V_{CTL} function can greatly optimize the PAE of the system at all four $Bluetooth^{tm}$ transmitted power levels.

By applying approximately 1.4V to V_{CTL} , for example, a Class1 radio can be modified to a Class2 radio with the PA2423G consuming only 15mA.

By implementing a resistor DAC, the V_{CTL} pin can interface with $\mathrm{Bluetooth^{tm}}$ transceivers offering digital and programmable outputs.



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